



AN INNOVATIVE DEPOSITION TECHNOLOGY
FOR CONDUCTIVE & DIELECTRIC MATERIALS
CONTACTLESS, HIGH RESOLUTION, HIGH SPEED



DIGITAL MANUFACTURING

Agenda

- Short Company Profile
- ioTech CLAD Technology
- From Single Material 2D
To Multi Material & 3D
- Use Cases

I O TECH - AT A GLANCE



Founded 2016



58 patents
39 granted



Team of 28 highly
skilled professionals



Prestigious POs &
industry awards



PROBLEM: ELECTRONICS MINIATURIZATION & RESHORING



SMALLER

Deposition technologies in semiconductor packaging & assembly are reaching their **limits**, hindering electronics miniaturization



CLEANER

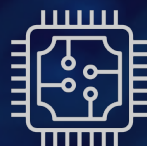
Many **semiconductor packaging technologies** cannot be re-shored due to **environmental issues**

UNMET NEED

Semiconductors
more chips per wafer



Semiconductor to memory
faster data transfer



Smart watches
4K display



Mobile acoustic
smaller



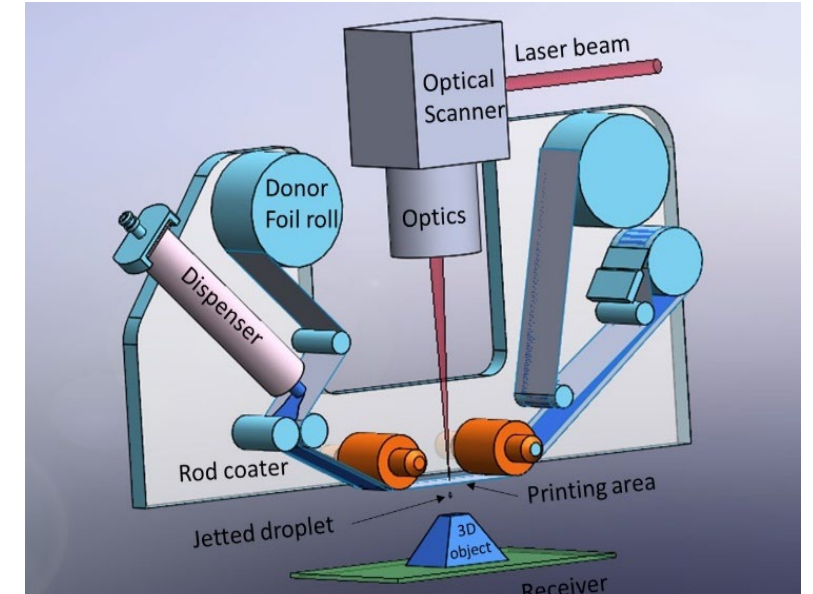
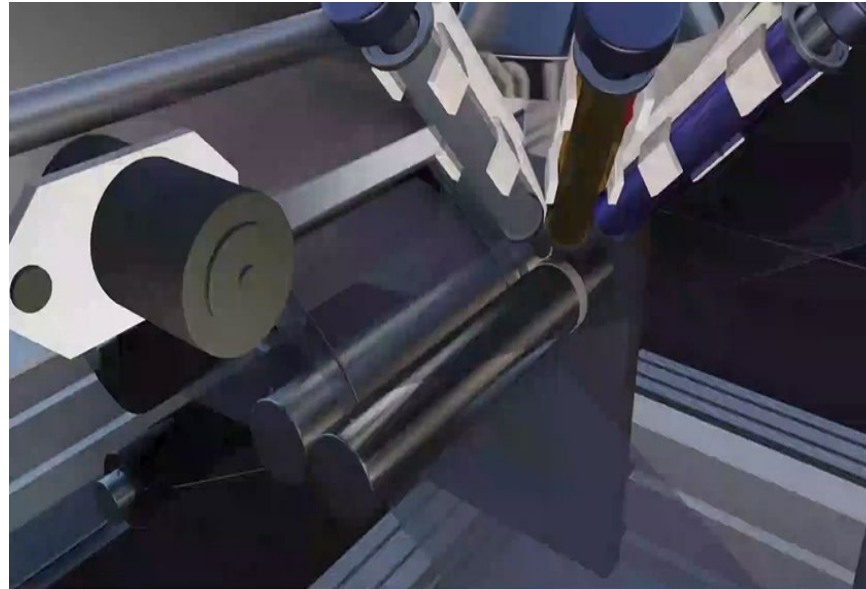
Semiconductor packaging
Re-shore to OECD



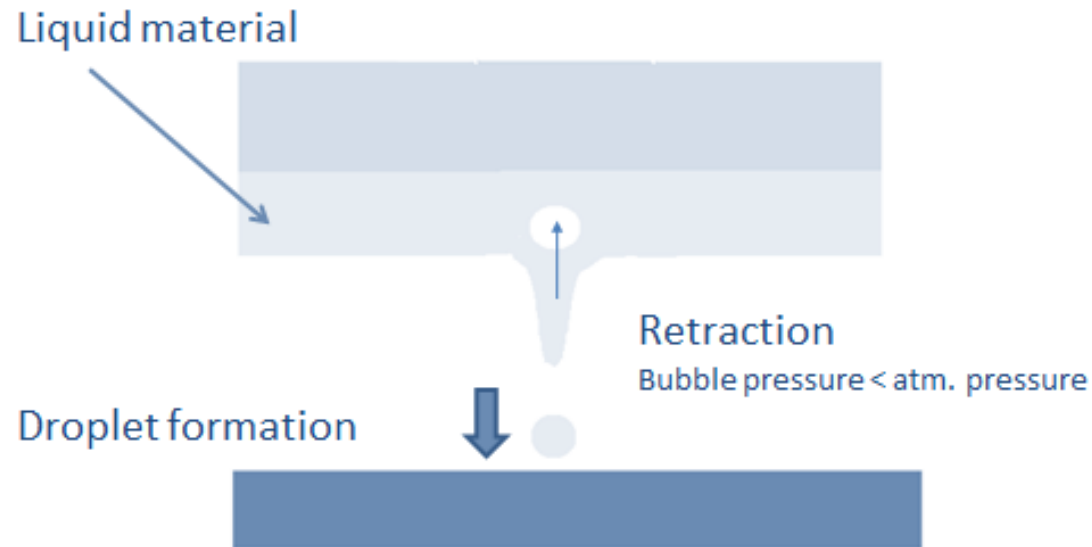
CLAD - non-contact & no mechanical motion

Full flexibility

- Low to high viscosities
- Filled Materials
- High Resolution
- High Speed
- Multi Layers
- Multi Materials



High-performance CLAD technology



Frictionless jetting,
=> No Stress
=> No Heat

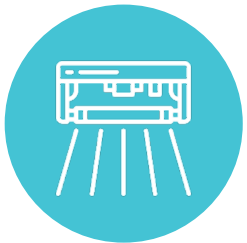
Laser can jet materials with
3,000 times higher viscosity
than Inkjet

Laser can pulse up to 10,000 dps

Integrated post-processing

Complete workflow to address complex structural builds

Multi Curing

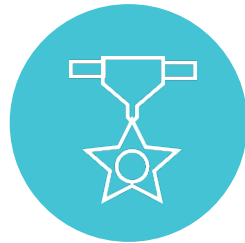


UV
curing

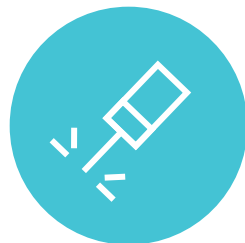


Thermal
curing

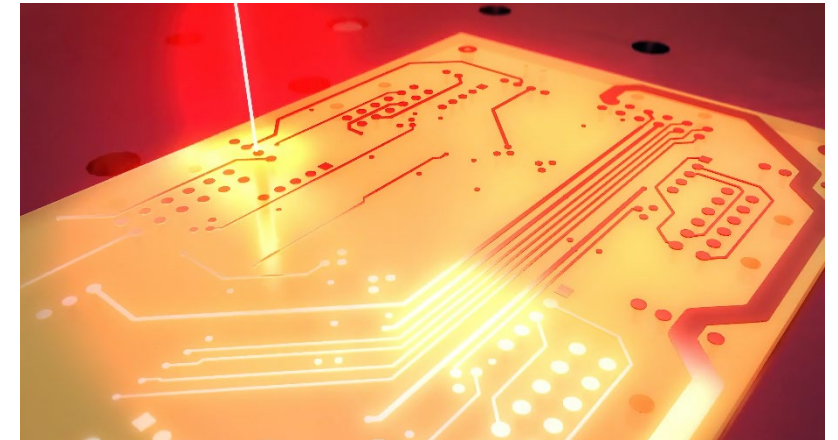
Finishing



Laser
sintering



Laser
ablation

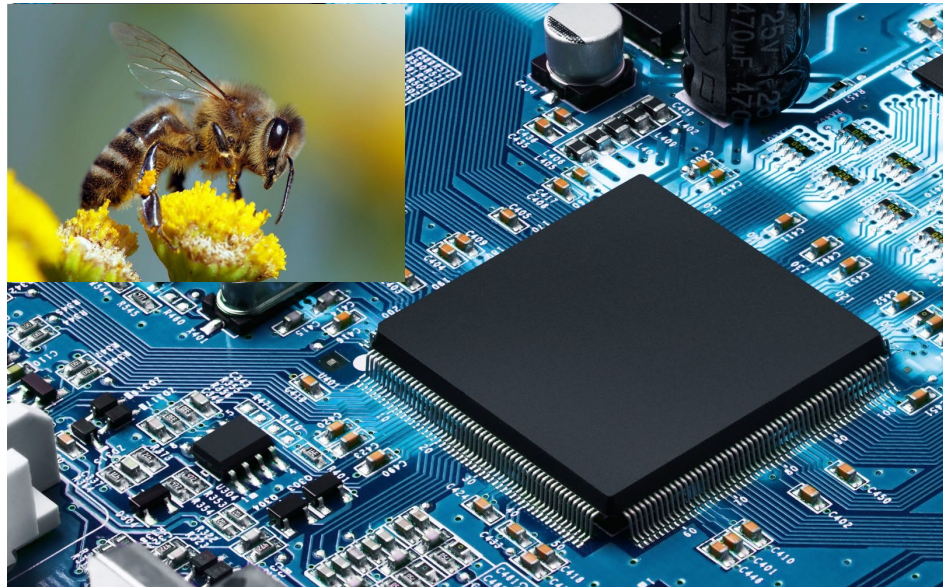


iotech increases sustainability

Replacing chemical subtractive processes

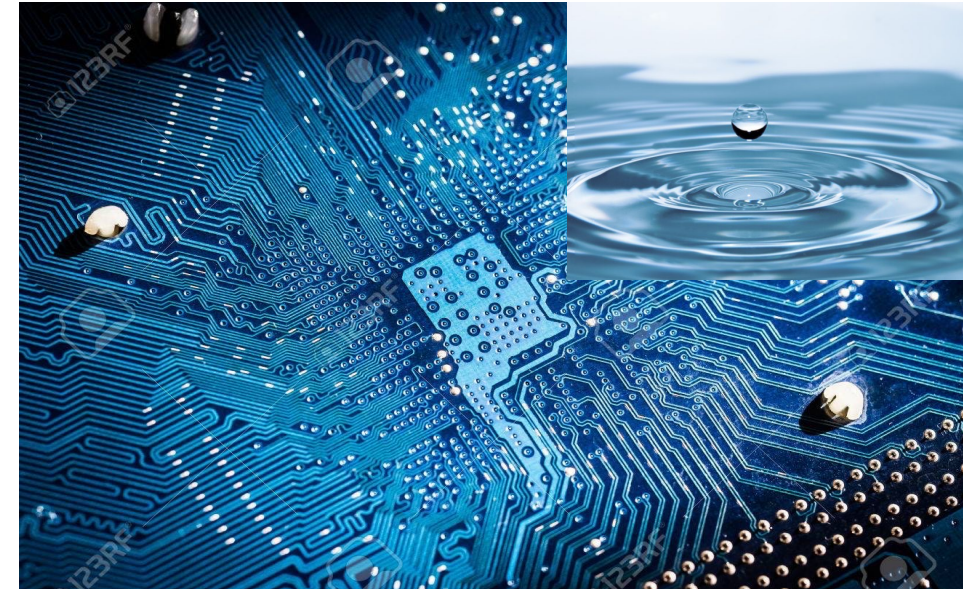


ACID & SOLVENT-FREE CHIP INTERCONNECTION



N-methyl-2-pyrrolidone

ONE TON OF WATER SAVED PER M² OF PCB



Standard materials printed using one single hardware setup

Material	Viscosity range (KcPs)	Cure type	Resolution	Filler size
Acrylate & Methacrylate	0.5-70	UV	40 μm	up to 2 μm
Epoxy - including Underfill & Flux	5-70	UV & heat	50 μm	up to 2 μm
Silicone - including Phosphor filled	10-300	UV & heat	100 μm	up to 2 μm
Metal paste (Ag & Cu)	5-40	Sintering	80 μm	0.1-5 μm
Solder paste - type 4 to 9	20-40		50 μm - 250 μm	3-35 μm
Solder mask	20-40	UV / heat	40 μm	up to 2 μm
Polyurethane (acrylate)	0.5-70	UV	40 μm	up to 2 μm
Ceramic paste	0.5-70		40 μm	up to 2 μm
Carbon paste	20-40		100 μm	wires of ~ 10 μm
Polyimides	0.5-2	UV	40 μm	up to 2 μm

*For all materials, resolution depends on filler size

Comparative table

	Any Industrial Material	Digital & Multi-Layer	Resolution (1)	Throughput (drops/hour) (2)	CAPEX vs Throughput
Screen printing	Y	N	50µm	15sec per screen	\$
Jet	N	Y	200µm	200Kdph drops/hour	\$\$\$
Needle-dispense	N	Y	150µm	10Kdph - 45 mm/sec	\$\$\$\$
Micro-dispense	N	Y	3µm	2Kdph – 10 mm/sec	\$\$\$\$
Inkjet	N	Y	30µm	2Mdph – 500 mm/sec	\$\$
Aerosol jet	N	Y	25µm	500dph – 5mm/sec	\$\$\$\$\$
IOTECH CLAD	Y	Y	30µm	7.5Mdph – 1,000 mm/sec	\$\$

(1) Resolution depends on the specific characteristics of each material.

(2) Throughput indicated is throughput that can be achieved, as opposed to “headline” throughput.

It all starts with dots

7,5M DPH

⇔ to over 1 meter/sec
line making

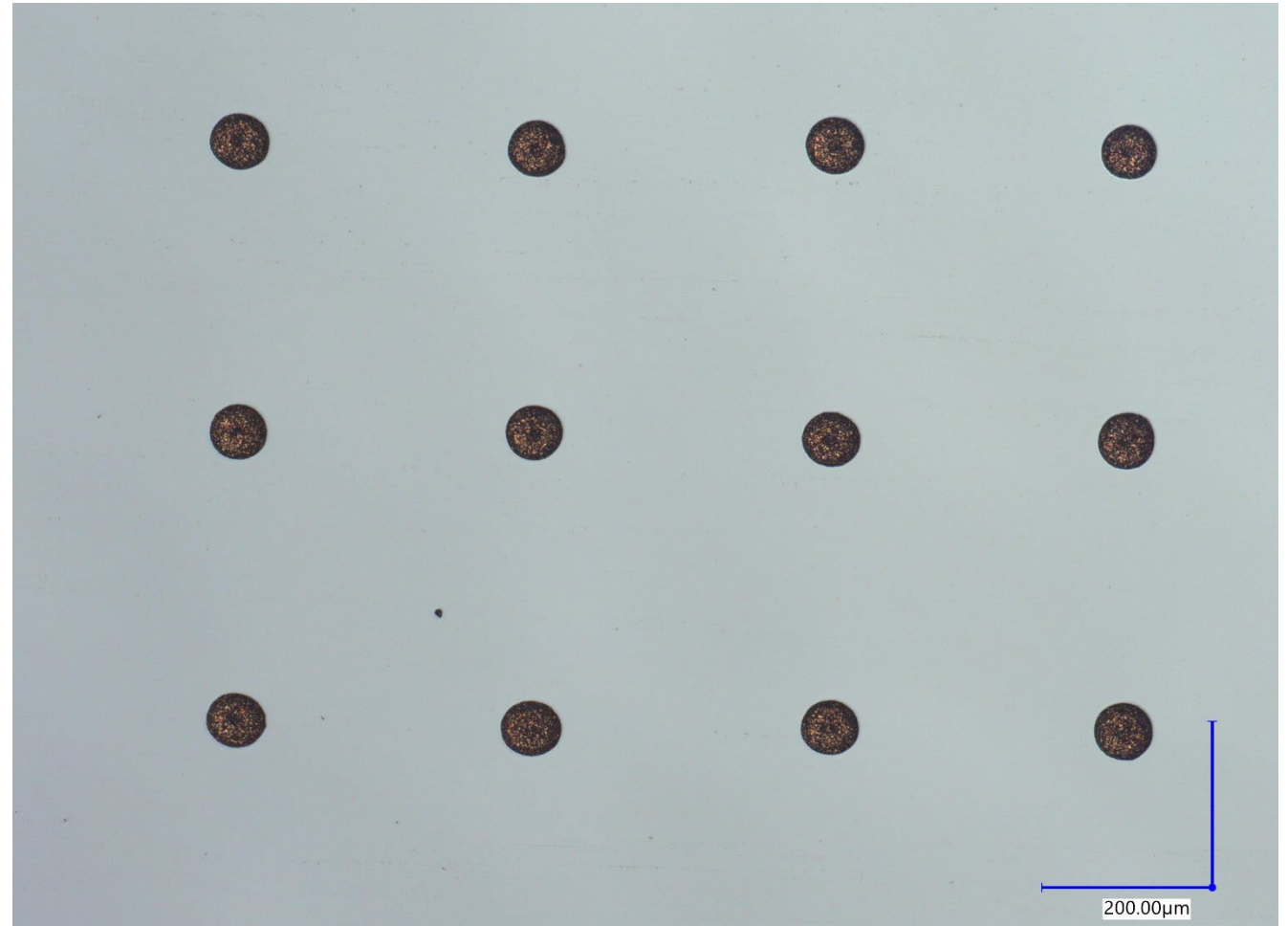
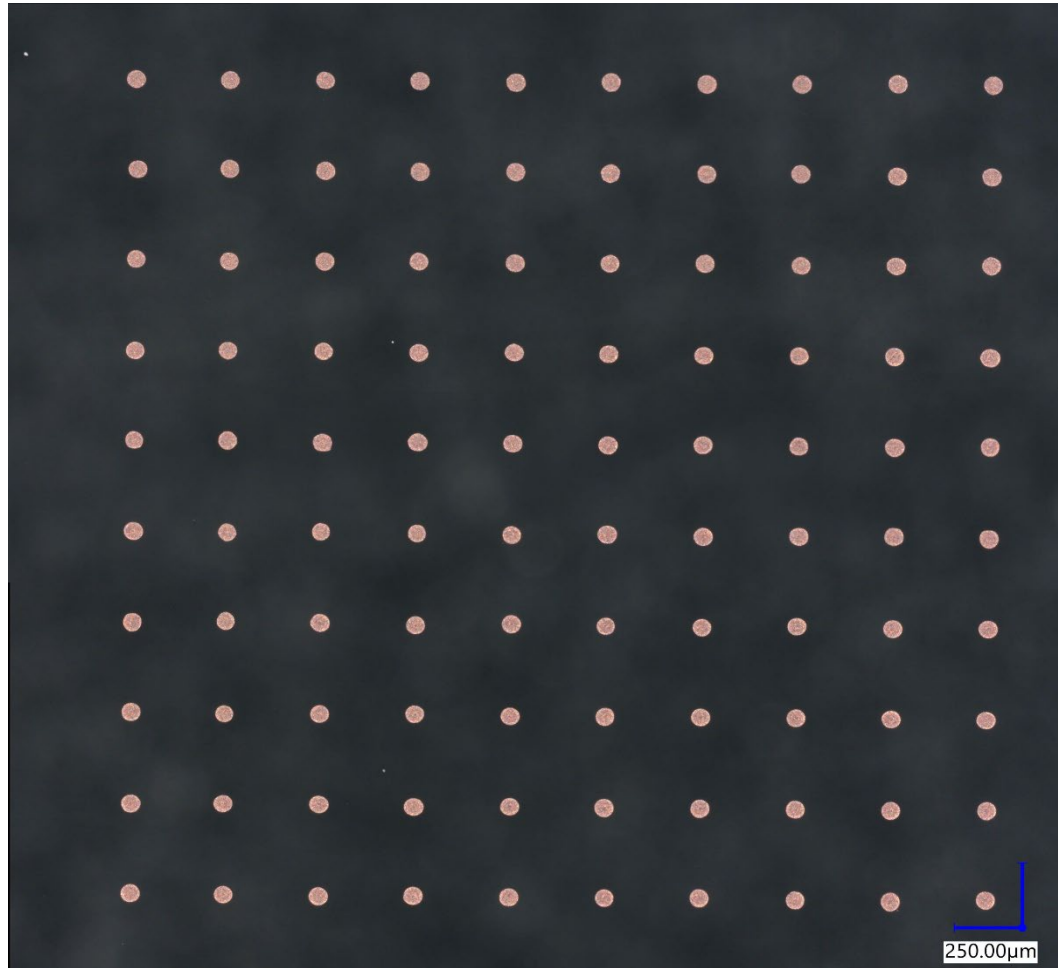
As the feature sizes get smaller stenciling cycle rate gets slower and has higher yield losses.

As feature shapes get more complex, robotic motion slows the cycle rate and generates dispensing inconsistency when doing patterns direction changes

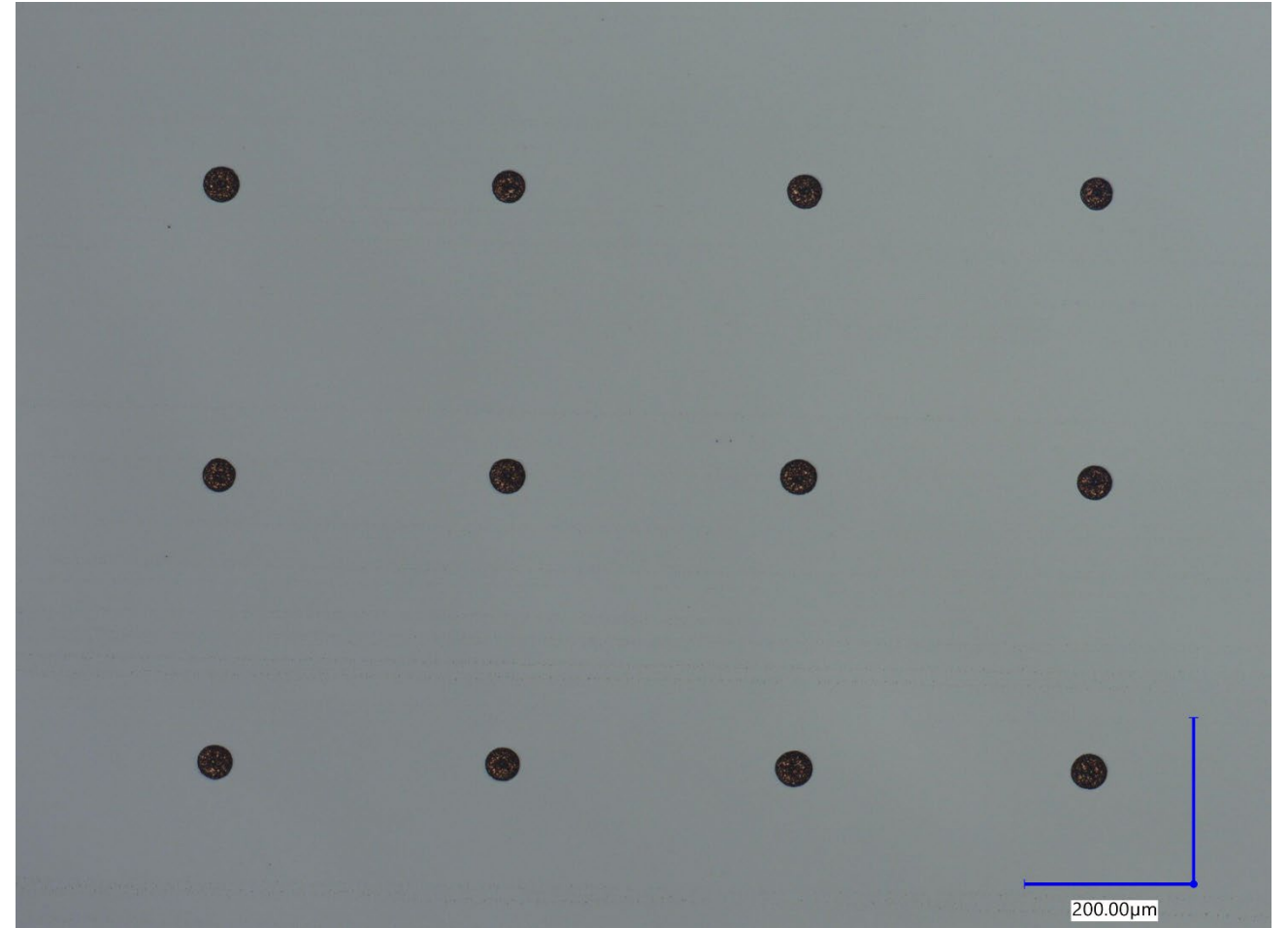
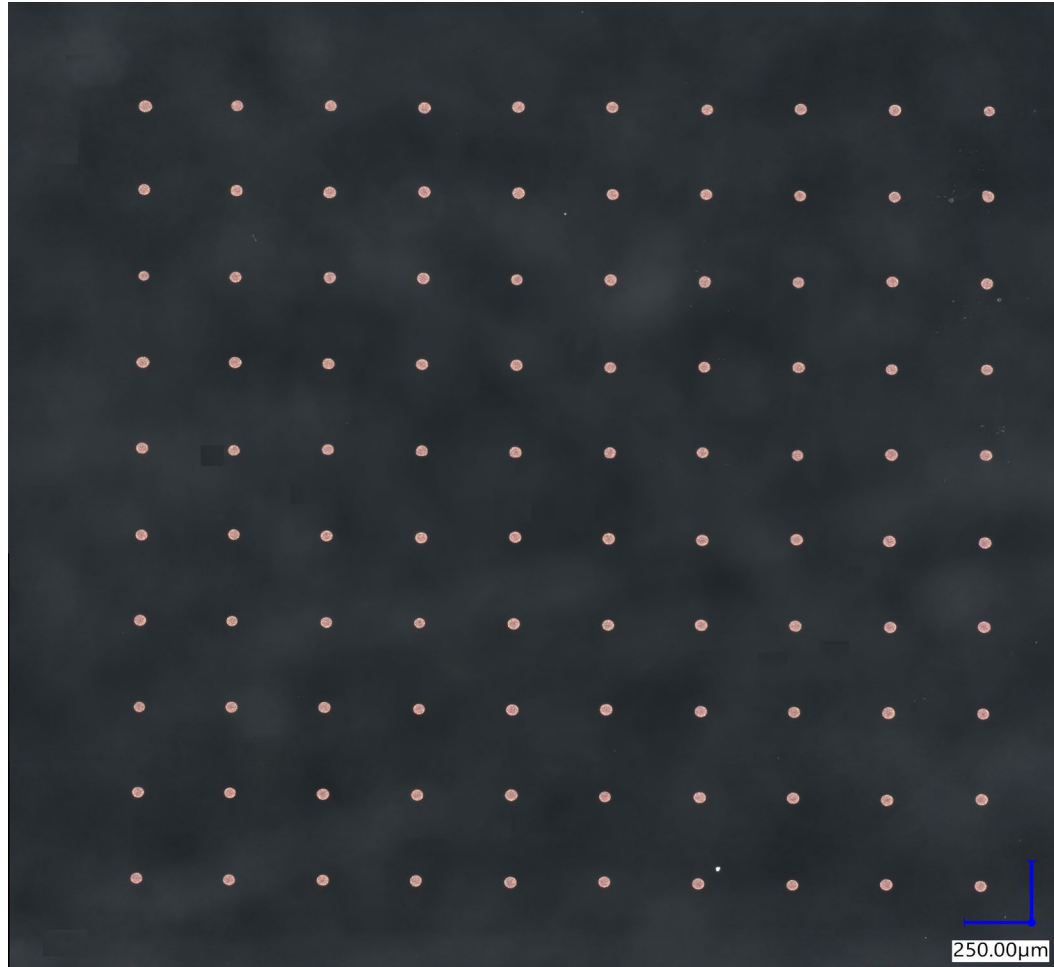
Video is slowed down 8 times



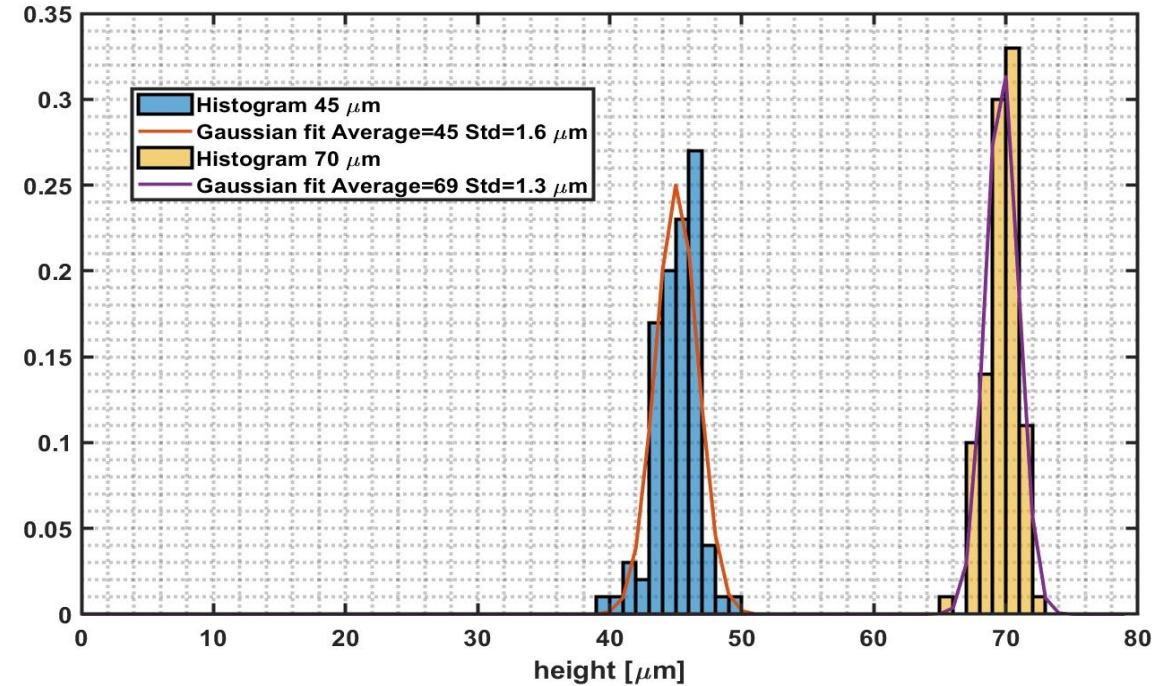
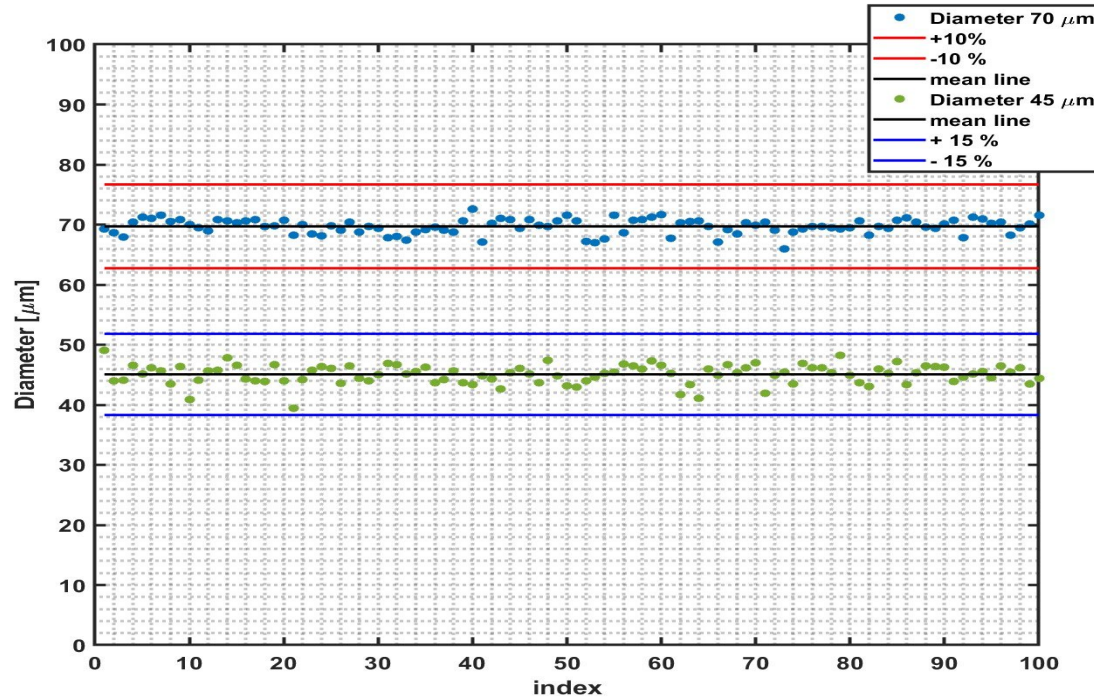
70-micron copper paste (Copprint)



45-micron copper paste (Copprint)



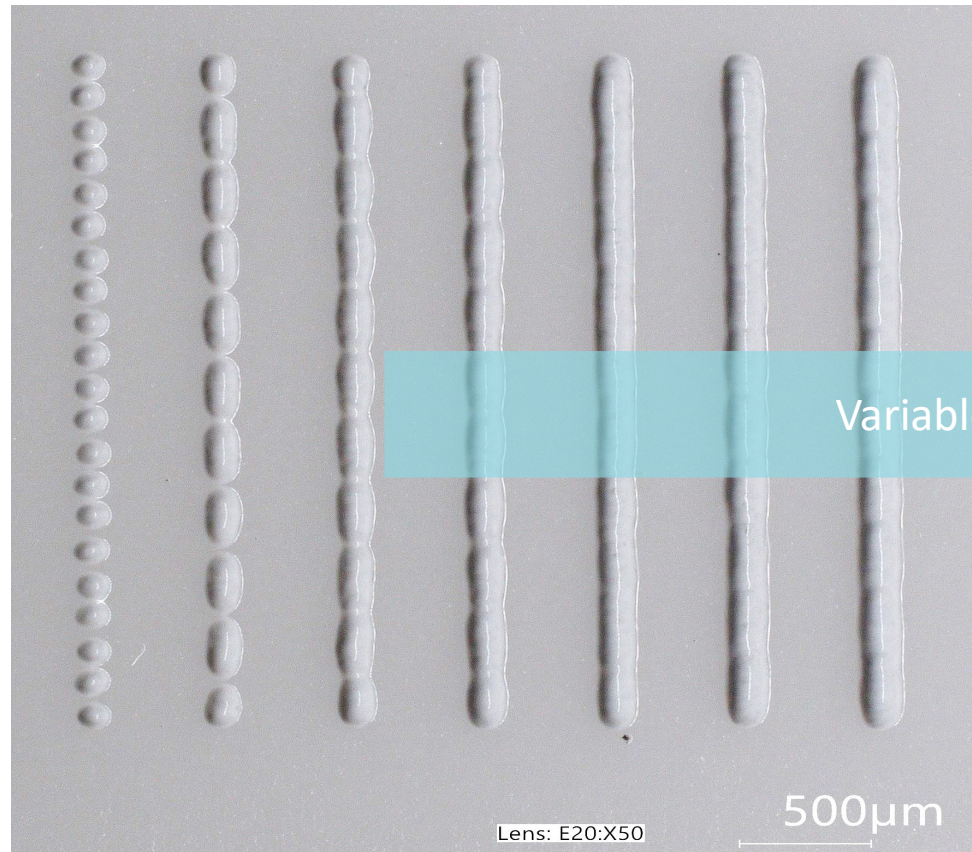
45- & 70-micron diameter copper paste (Copprint) statistical results over a population of 100 drops



	Diameter [μm]	STD [μm]	Cpk +/-15%	Cpk +/-10%
Case 1	45	1.6	1.4	0.93
Case 2	70	1.3	2.7	1.8

Making lines & the role of drops overlap

Width 150 μ m H=50 μ m



Width 1500 μ m H=100 μ m



High resolution 2D

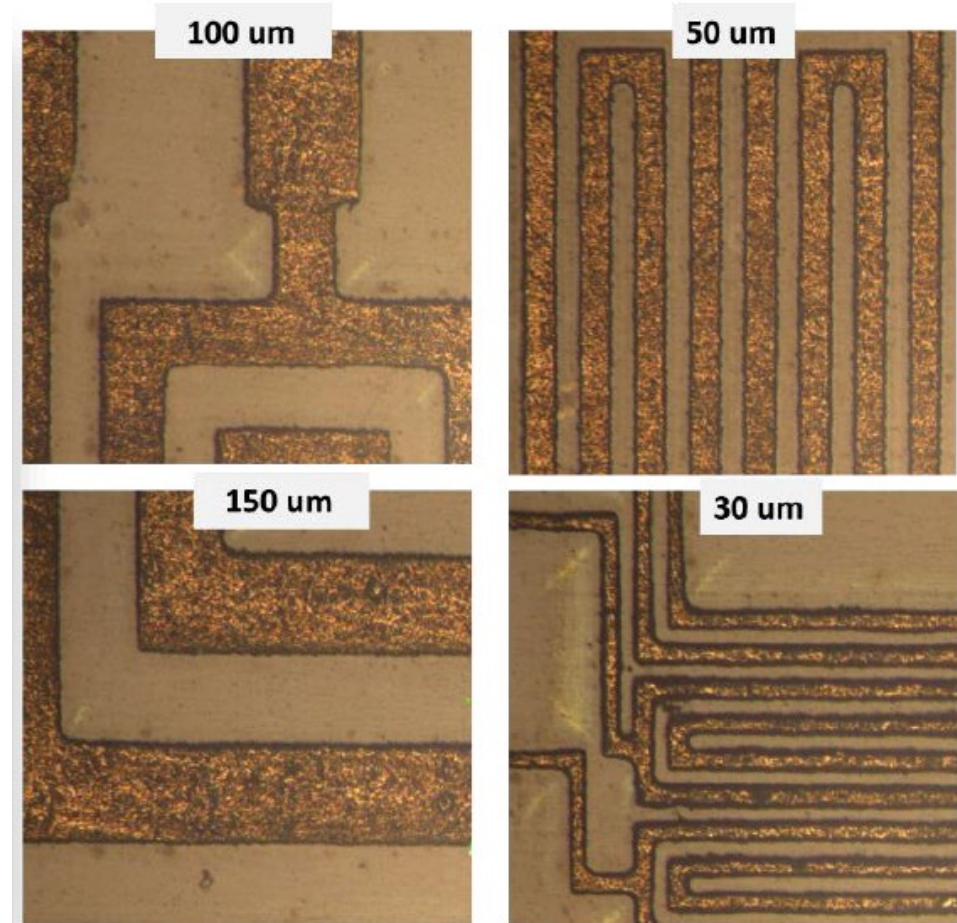
- Dynamic line resolutions down to 40µm
- Positioning wet accuracy 10µm

Here a standard silver ink from Henkel is applied with different laser power and laser beam settings

30 µm line width:

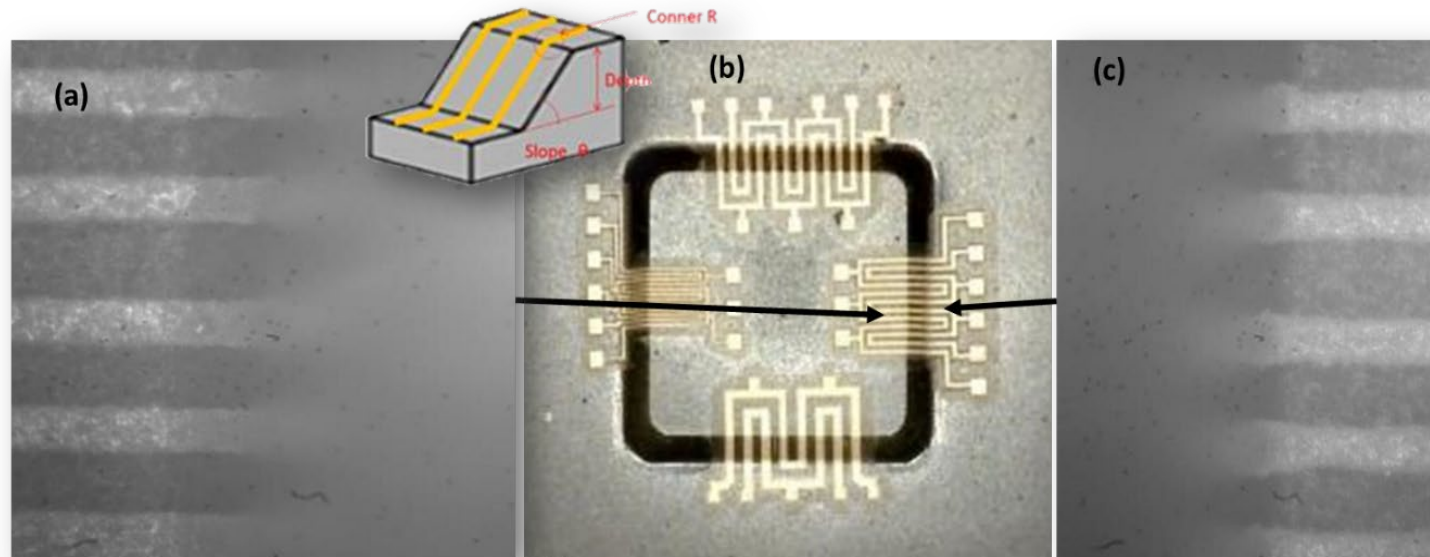
5 times smaller than jetting

2 times smaller than stenciling



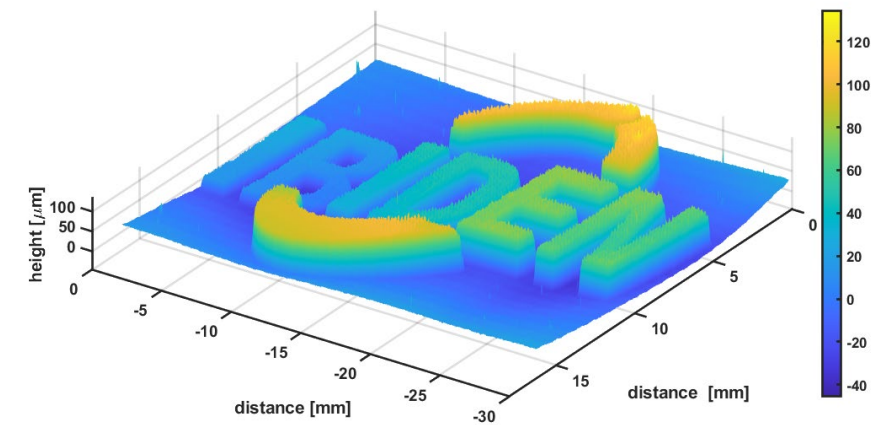
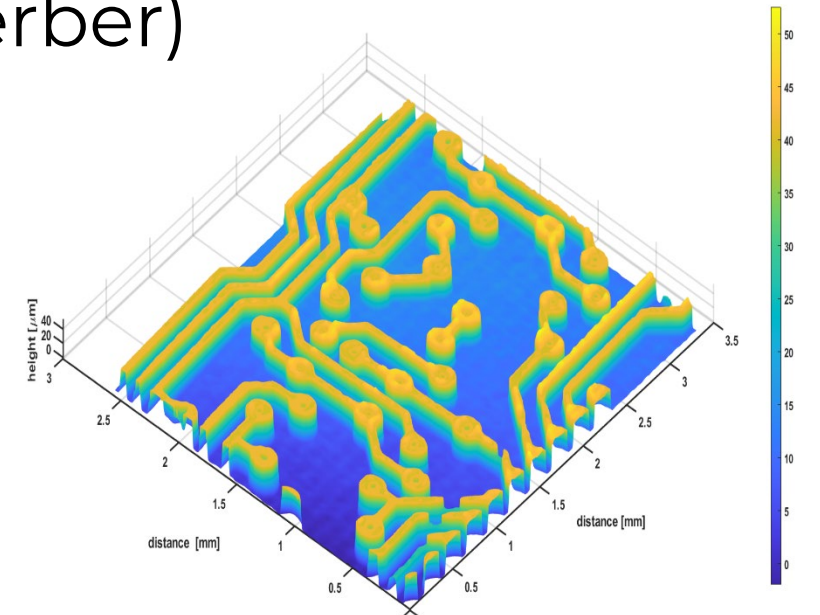
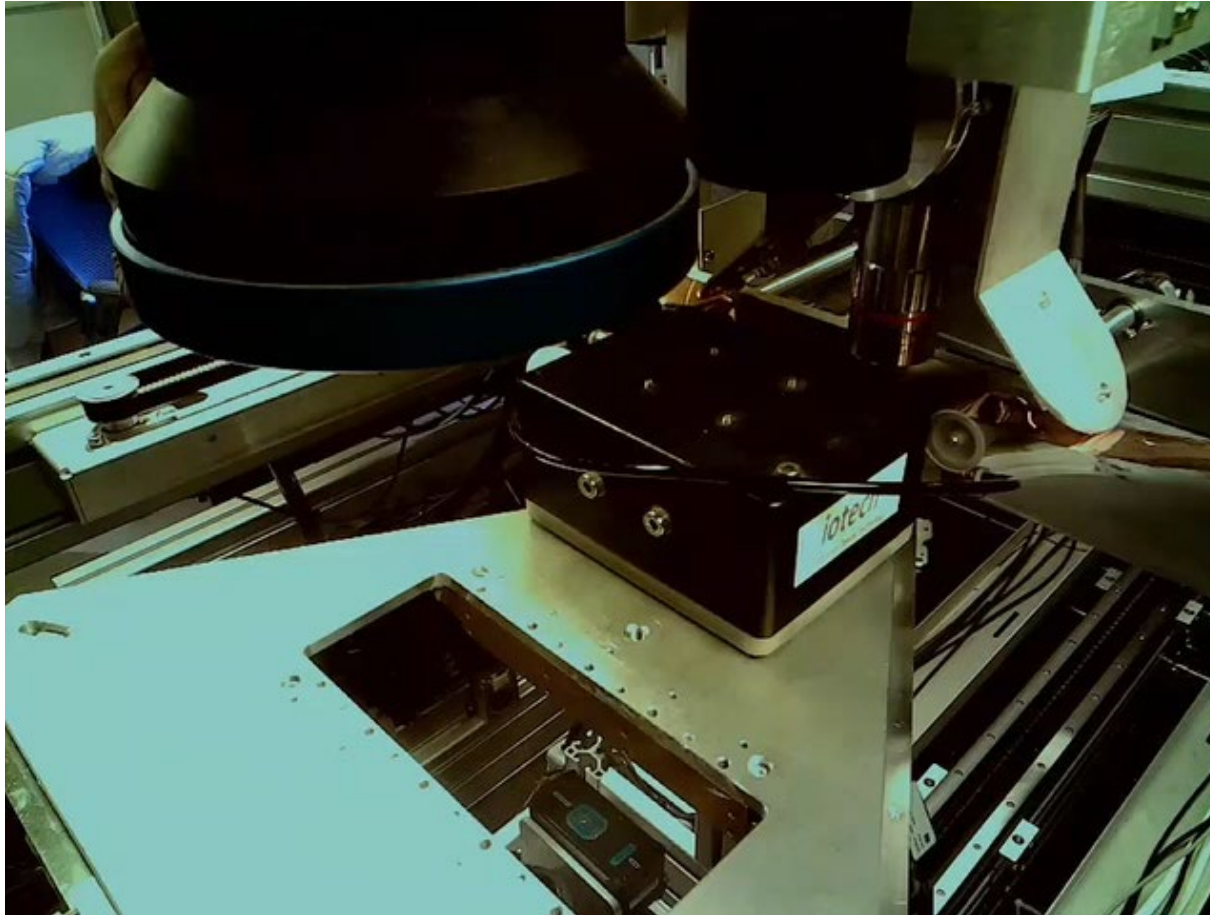
Conductive interconnect on a slope

- Line width down to 20 μ m with laser ablation
- Inline laser sintering of the line
- Standard commercial metallic pastes, copper, silver,.
- Printing on non-conformal substrates with slopes of up to 70%
- Designs combining dielectric and metal



(b) conductive pattern printed in a cavity with a slope of 70%
(a) microscope picture of the bottom of the cavity and
(c) of the top of the cavity

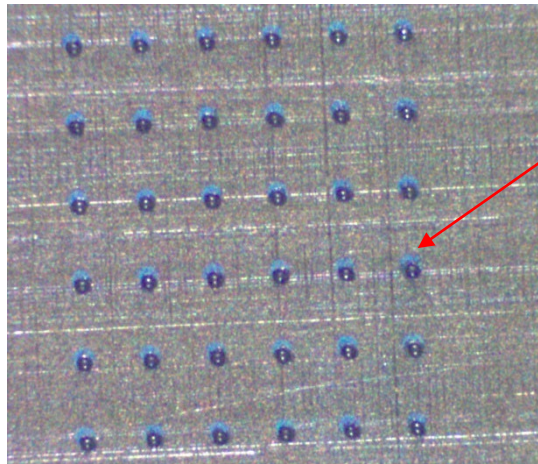
Copper Based Conductive Material Deposition of Complex Geometry from a CAD File (Gerber)



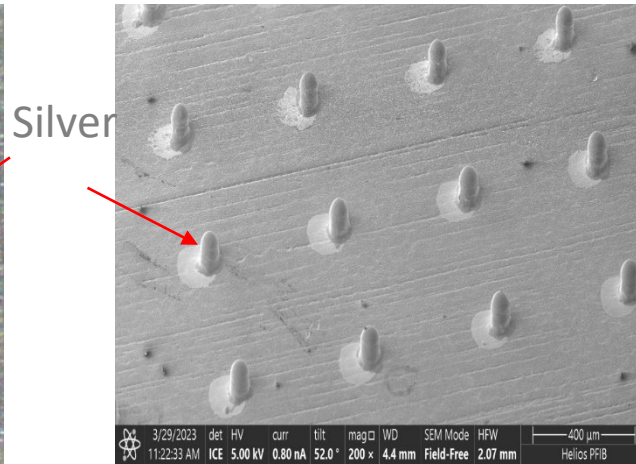
Multi layers capability offering 3D variants

High resolution 3D

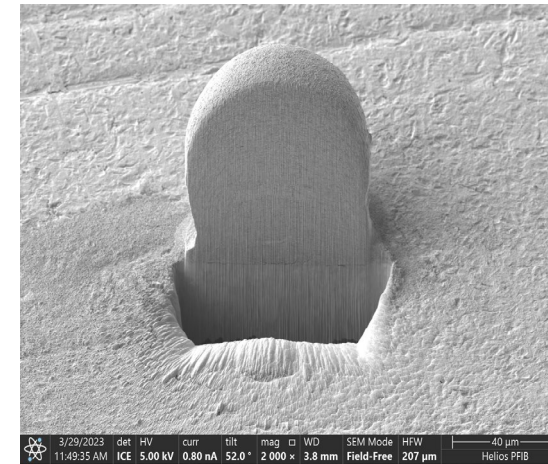
Microscope top view



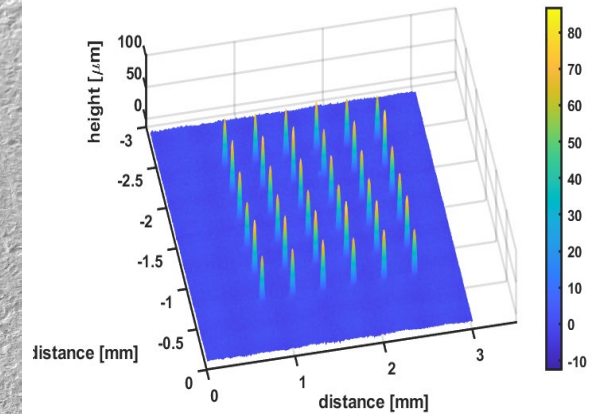
SEM side view



Cross Section



Topography



Vertical interconnexions
down to 50 µm diameter
up to x2 form factor

Vertical Interconnect

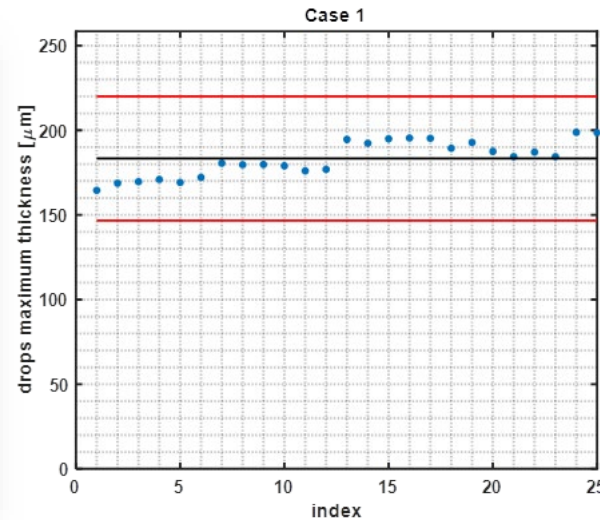
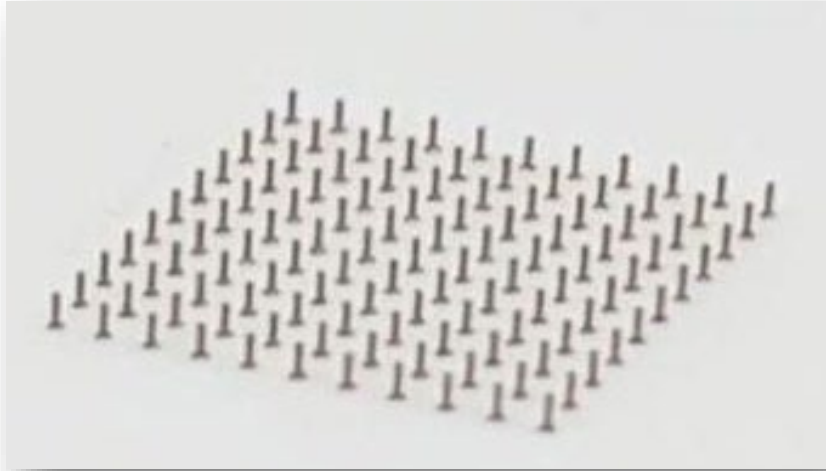
Multi-Material

Copper – Silver – Nickel - SAC

Iterative Multi-Process

Laser Deposition
Heat Cure

Example of pillar printed on ceramic



Multi-material stacking:

- Copper
- Silver
- Nickel
- SAC 305

High-resolution

Hmax = 183 +-15 micron

Radius = 87+-10 micron

Next Generation will use close loop iterative droplet deposition

High productivity:

Stack of 32 droplets (70μm diam)

Using a 200 mm wafer, pitch of 200 μm between pillars, print speed @ 10k drops/s

=> 100s per layer and additional drying time of 10s per layer.

=> **1M pillar/hour**

Bridge / Interconnect build

Multi-Material

Copper – UV Curable Dielectric – Silver

Multi-Process

Laser Texturation

Laser Deposition

Laser Ablation

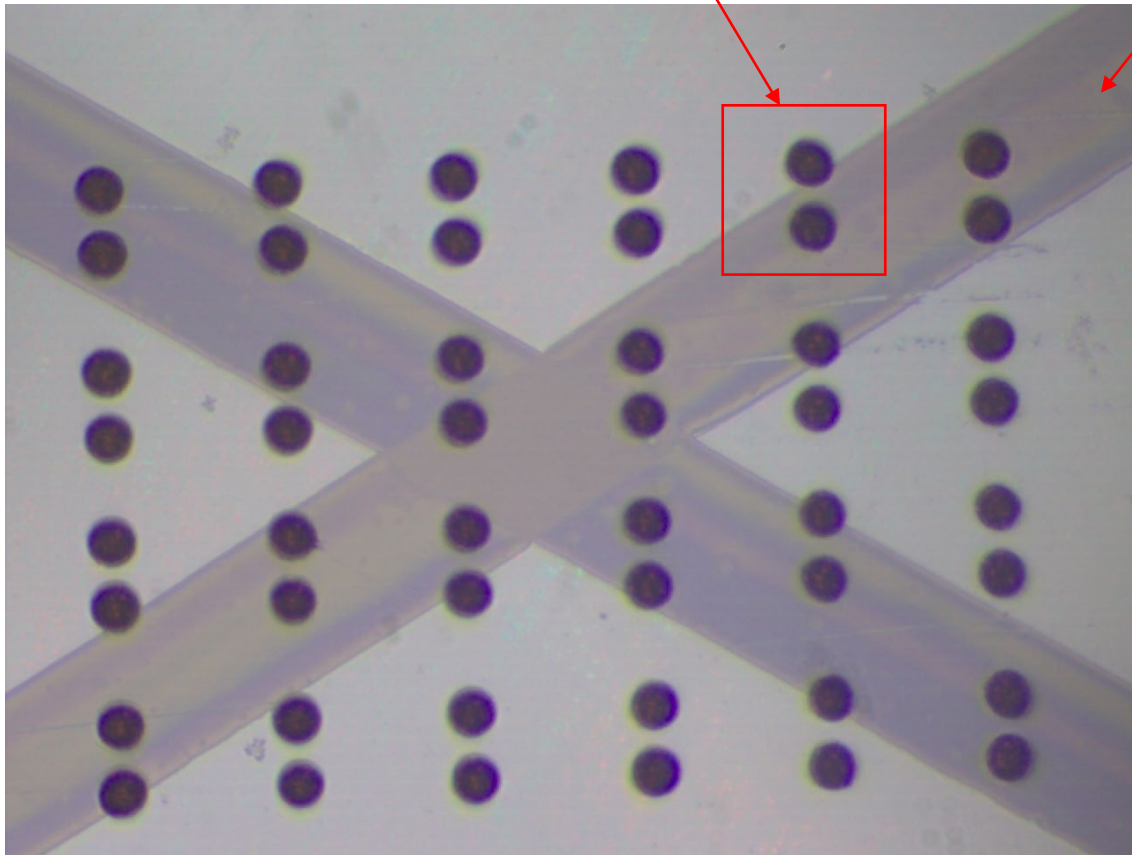
Heat Cure

UV Cure

Printing of drops

One cell of two pads

Manual cross mark in the bottom of the glass



140 μm Diameter – 15 μm Thickness

Parameters

Drop volume (pulse energy, layer thickness, spot size)

Number of drops

In case of multiple drops shift/pattern between drops

Material, it possible to add silver coating

Distance between the center of the drops

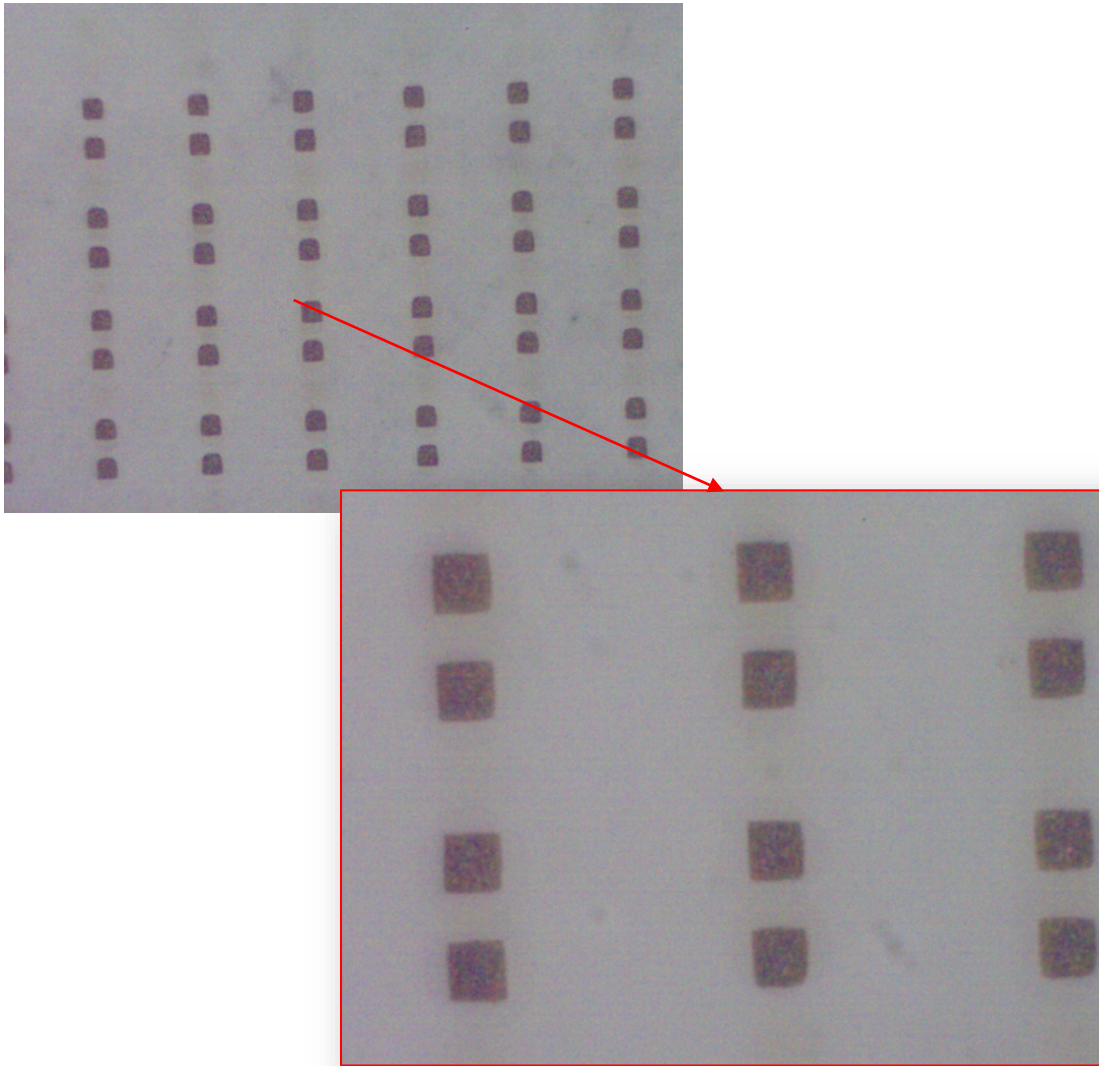
Procedure

Coat a layer of material on the foil

Bring the sample in front to the foil at the right distance

Print with the laser

Laser Ablation



Parameters

Scanning speed

Pulse energy

Number of pass

Pulse density

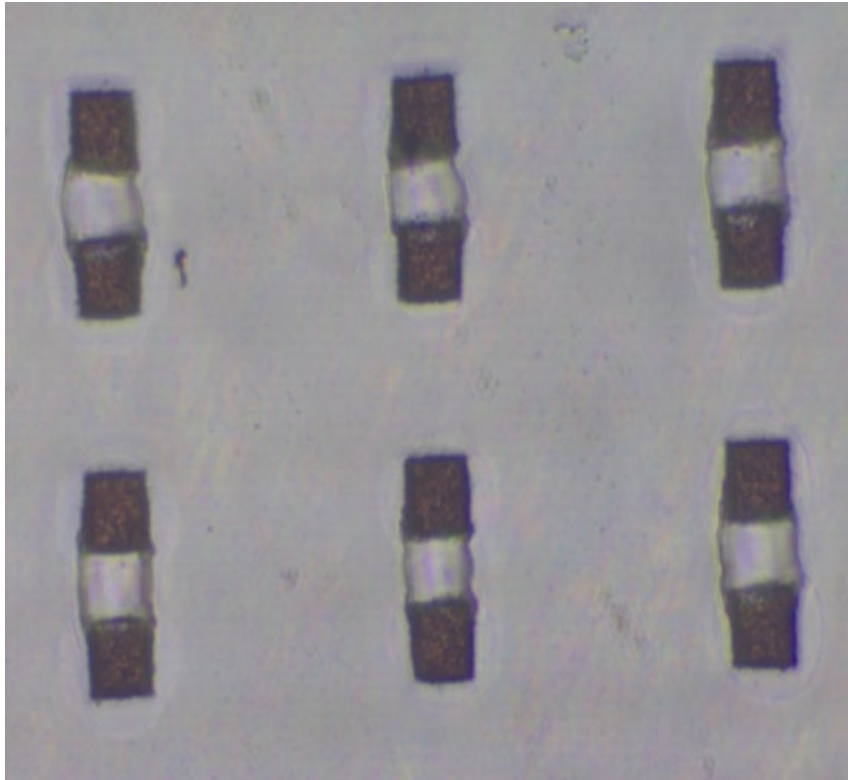
Procedure

Print head move, sample is in front of the laser scanner

Laser Ablation

80 x 80 μm squares – 15 μm thickness

Dielectric Printing



100 x 100 μm – 15 μm thick

Parameters

Drop volume (pulse energy, layer thickness, spot size)

Number of drops

In case of multiple drops shift/pattern between drops

Material type

UV irradiance and time between drops

Air temperature/flow and time

Procedure

Coat a layer of material on the foil

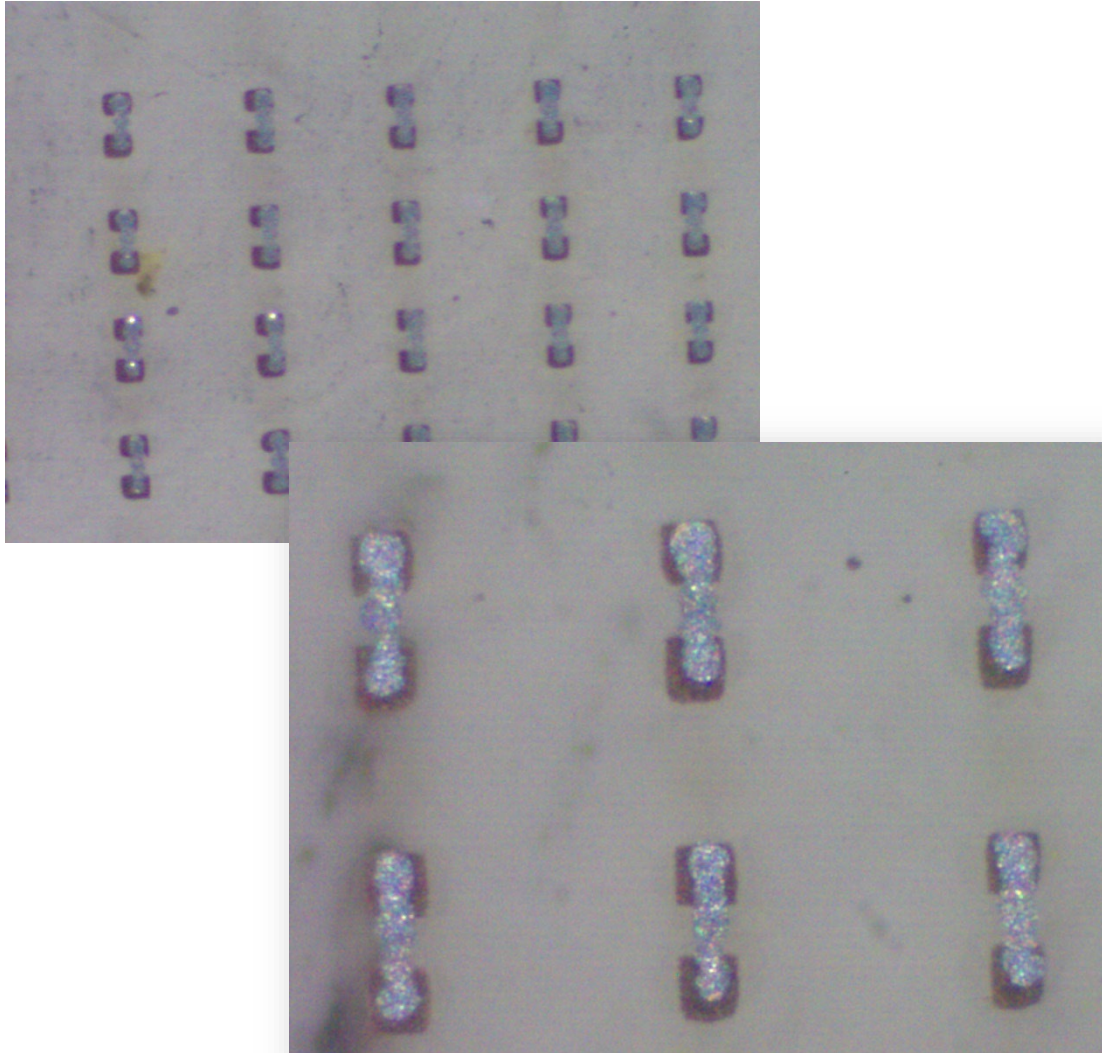
Bring the sample in front to the foil at the right distance

Print with the laser

Remove print head and bring UV head in front of sample and UV cure

At the end of the multi-drop procedure bring heat cure head in front
the sample and heat cure

Interconnect Printing (Bridge)



Parameters

Drop volume (pulse energy, layer thickness, spot size)

Overlap of the drops

Printing strategy

Material, it possible to add silver coating

Number of layer

Procedure

Coat a layer of material on the foil

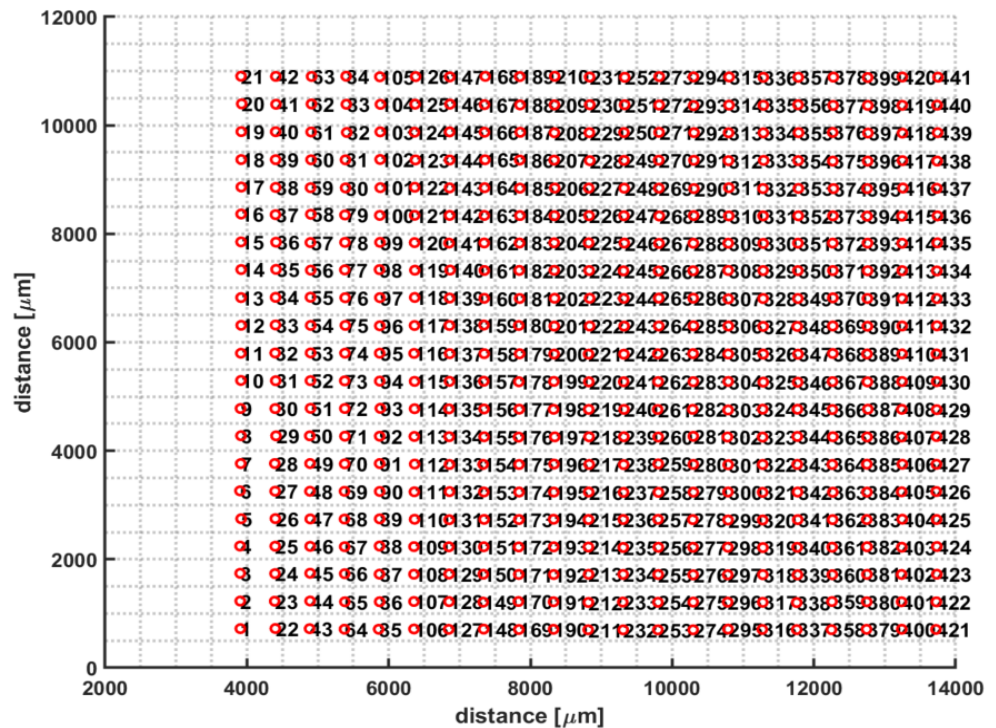
Bring the sample in front to the foil at the right distance

Print with the laser

Line width 60 μm – line length 250 μm – thickness 8 μm

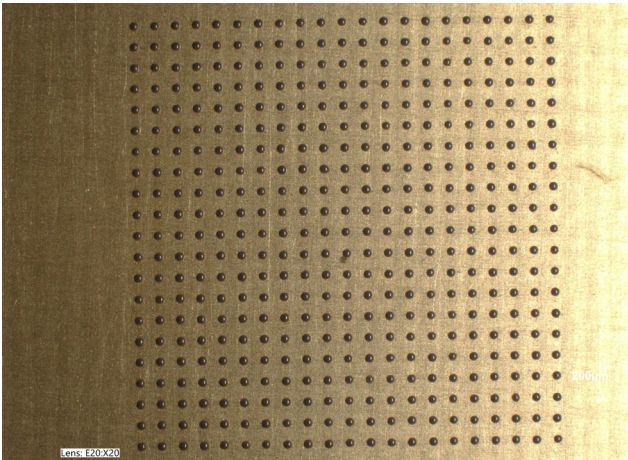
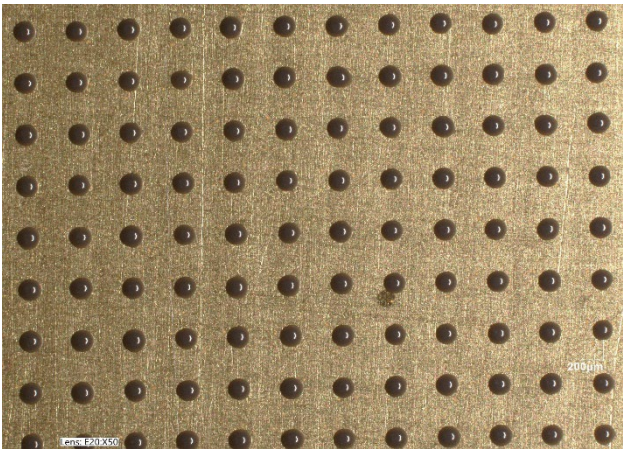
Use case 2 – semiconductor packaging

Low Viscosity Epoxy Base
Materials :
UNDERFILL / Flux



	AVERAGE	STD	3sigma
POSITION X	509.29	6.37	9.55
POSITION Y	491.04	5.64	8.46
DIAMETER	212.76	7.00	10.50

Weight test results: 21x21x9 = 3,969 drops



#	Printed materials
	Weight [mg]
1	2.2
2	2.2
3	2.2
4	2.3
5	2.2
6	2.2
7	2.1
8	2.1
9	2.1
10	2.2
STD	0.0632
3sigma	0.0948
drop weight [µg]	
0.5492	

Use case – semiconductor packaging

Flip chip underfill @ wafer level

UNDERFILL MATERIAL	CLIENT NEED	CURRENT DISPENSER	IOTECH
Systems		500 Jet dispensers	20 CLAD systems
Productivity	100M drop/hour	200,000/hour	5,000,000/hour
Keep-Out Zone (KOZ)	<400µm	650µm	350µm
Design flexibility *	Square Corners No Satellite's	Not Possible	Full Match
Clean room		1,000m ²	80m ²
Employees		250	20

* Reducing the KOZ allows to increase the die density per wafer by 10%



A DISRUPTIVE TECHNOLOGY FOR ELECTRONICS MANUFACTURING



THANK YOU